



FQB19N10 / FQI19N10

100V N-Channel MOSFET

General Description

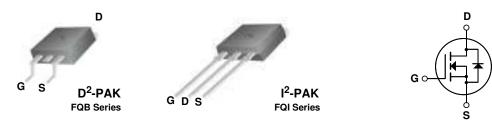
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

Features

- 19A, 100V, $R_{DS(on)}$ = 0.1 Ω @V_{GS} = 10 V Low gate charge (typical 19 nC)
- Low Crss (typical 32 pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · 175°C maximum junction temperature rating
- RoHS Compliant





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB19N10 / FQI19N10	Units
V _{DSS}	Drain-Source Voltage		100	V
I _D	Drain Current - Continuous (T _C = 25°C)		19	Α
	- Continuous (T _C = 100°C)		13.5	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	76	Α
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	220	mJ
I _{AR}	Avalanche Current (Note 1)		19	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	7.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
P_{D}	Power Dissipation (T _A = 25°C) *		3.75	W
	Power Dissipation (T _C = 25°C)		75	W
	- Derate above 25°C		0.5	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA		100			V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C			0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100 V, V _{GS} = 0 V				1	μΑ
		V _{DS} = 80 V, T _C = 150°C				10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -25 V, V _{DS} = 0 V				-100	nA
On Cha	racteristics		1				
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 9.5 A			0.078	0.1	Ω
9FS	Forward Transconductance	V _{DS} = 40 V, I _D = 9.5 A	(Note 4)		12		S
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			600	780	pF
C _{oss}	Output Capacitance				165	215	pF
C _{rss}	Reverse Transfer Capacitance				32	40	pF
Switchi	ng Characteristics						
t _{d(on)}	Turn-On Delay Time	V 50 V L 10 A			7.5	25	ns
t _r	Turn-On Rise Time	$V_{DD} = 50 \text{ V}, I_{D} = 19 \text{ A},$ $R_{G} = 25 \Omega$			150	310	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4, 5)			20	50	ns
t _f	Turn-Off Fall Time				65	140	ns
Qg	Total Gate Charge	V _{DS} = 80 V, I _D = 19 A,			19	25	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4, 5)			3.9		nC
Q _{gd}	Gate-Drain Charge				9.0		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings					
I _S	Maximum Continuous Drain-Source Diode Forward Current					19	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current				76	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 19 \text{ A}$				1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 19 \text{ A},$			78		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)			200		nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.9mH, I_{AS} = 19A, V_{DD} = 25V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq 19A, di/dt \leq 300A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

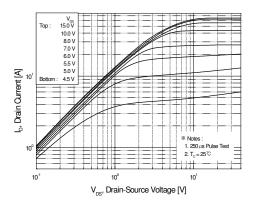


Figure 1. On-Region Characteristics

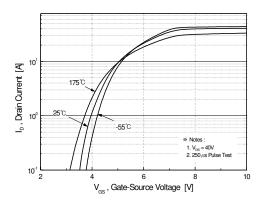


Figure 2. Transfer Characteristics

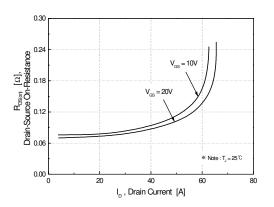


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

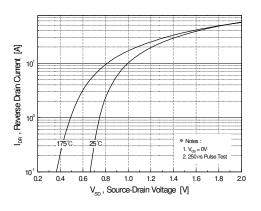


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

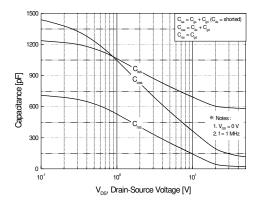


Figure 5. Capacitance Characteristics

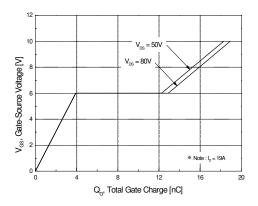
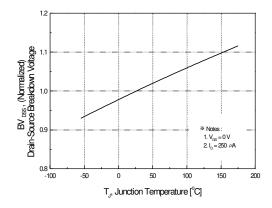


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)



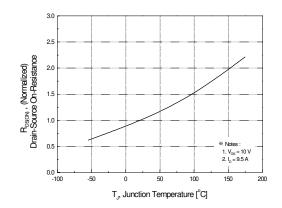
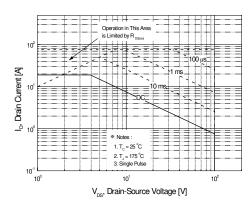


Figure 7. Breakdown Voltage Variation vs. Temperature





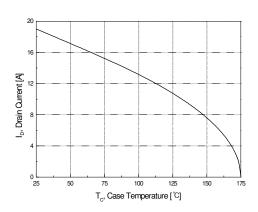


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

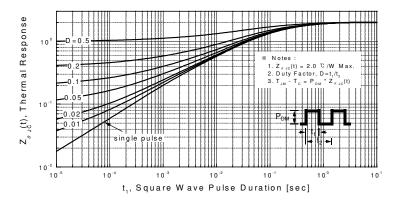
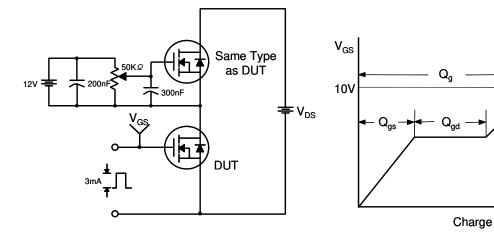


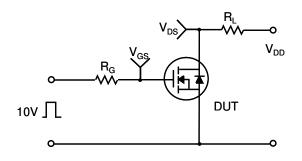
Figure 11. Transient Thermal Response Curve

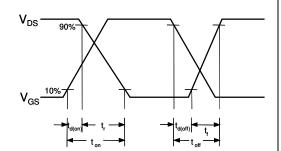
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Gate Charge Test Circuit & Waveform

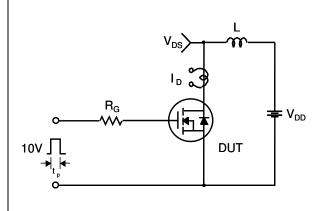


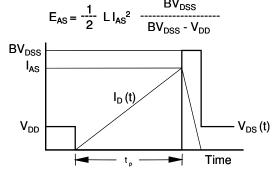
Resistive Switching Test Circuit & Waveforms



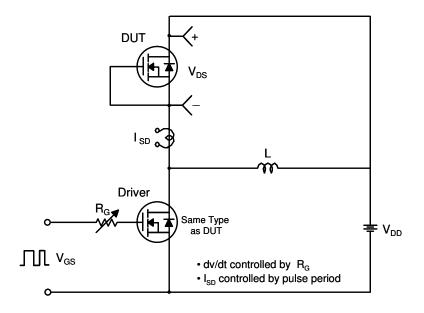


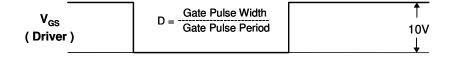
Unclamped Inductive Switching Test Circuit & Waveforms

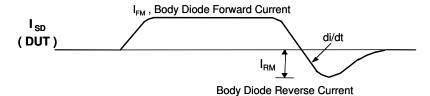


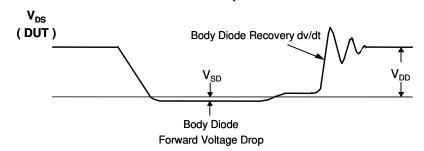


Peak Diode Recovery dv/dt Test Circuit & Waveforms





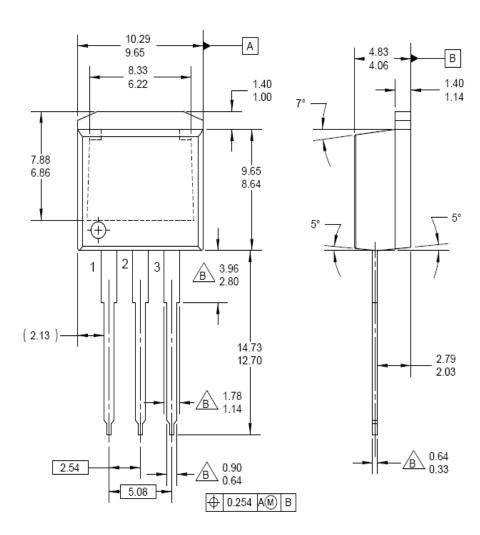




Mechanical Dimensions D² - PAK -A-10.67 9.65 9.50 MIN-9.00 MIN 1.78 MAX 10.00 3 (2.12) ---1.50 MIN 0.25 M B AM - 5.08 -LAND PATTERN RECOMMENDATION -B-4.83 4.06 -6.22 MIN-1.65 1.14 6.86 MIN 15.88 14.61 SEE DETAIL A GAGE PLANE 0.25 △ 0.10 B .25 MAX SEATING **DETAIL** Dimensions in Millimeters

Mechanical Dimensions

I² - PAK



Dimensions in Millimeters





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